

# Lunar photoemission yields inferred from ARTEMIS measurements

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# Introduction & Motivation

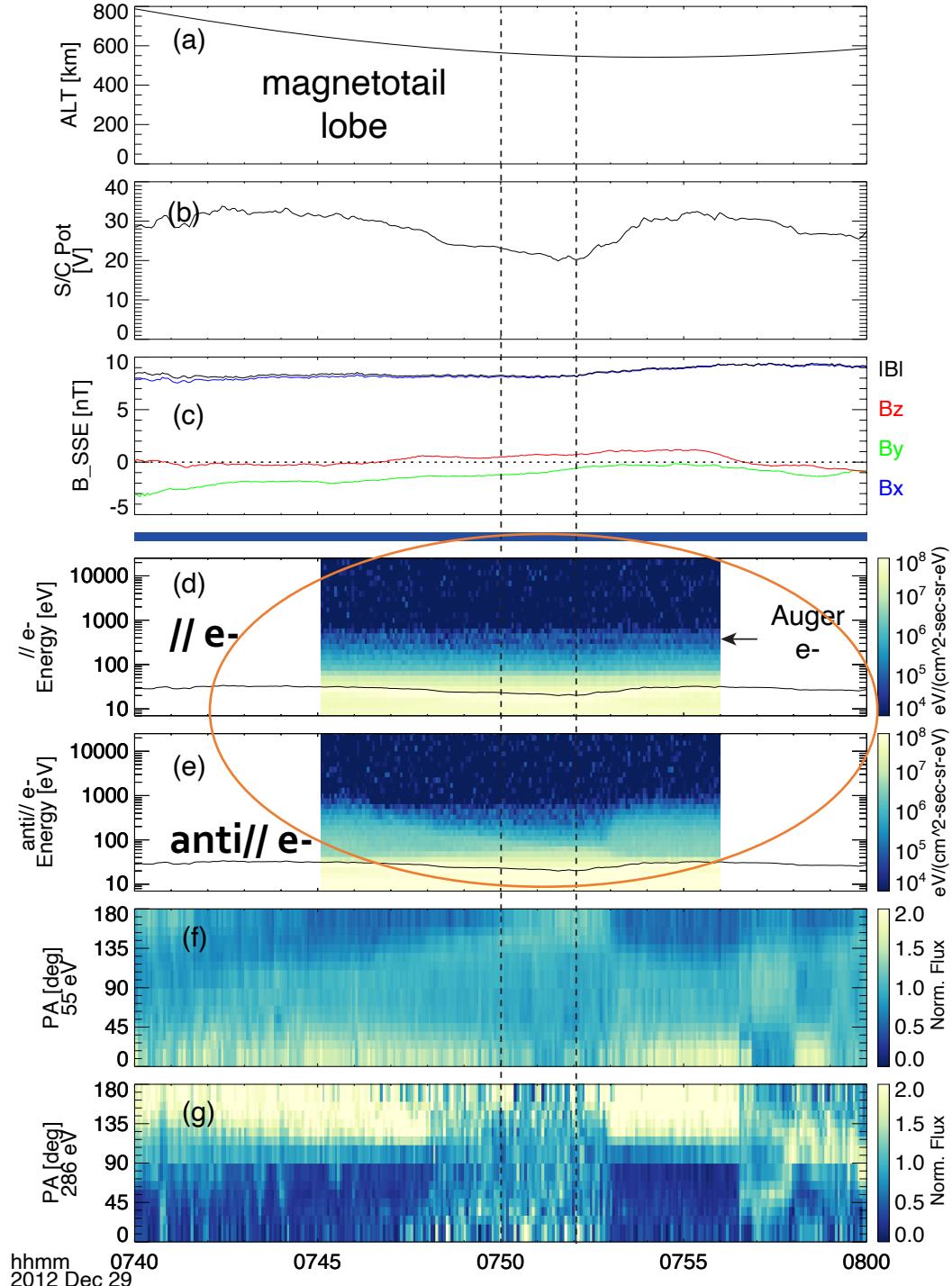
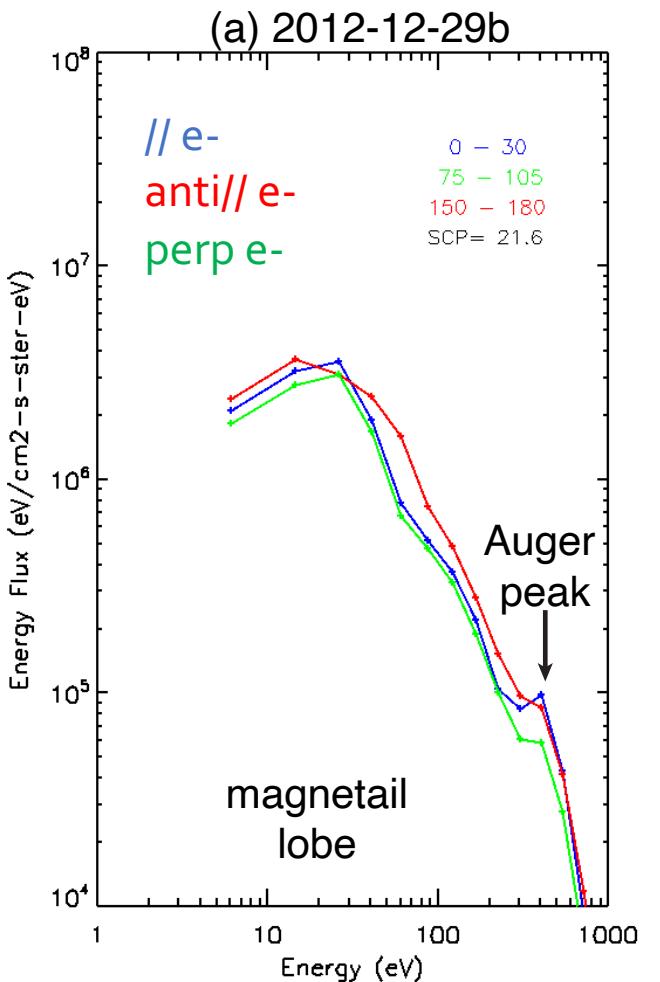
- Photoemission yield
  - the number of emitted photoelectrons per incoming photon
  - one of the fundamental properties of solid materials, here lunar surface
  - *not yet well constrained for photon energies  $>\sim 20$  eV*
- Important for characterizing lunar surface charging environment
  - Surface potential varying drastically in different plasma environments
  - Solar photon flux variations (solar cycle, solar rotation, solar flares etc)
  - Better surface charging modeling if photoemission yield at high energy available

# Case Study: Lunar Photoelectrons and Auger Electrons

- Auger e-
  - ionization of inner shell e-
  - peak in flux at fixed energy, ~500 eV for O
  - a unique feature to identify lunar surface photo e- & surface atomic comp.
- **first report**
- Solving photoemission yield

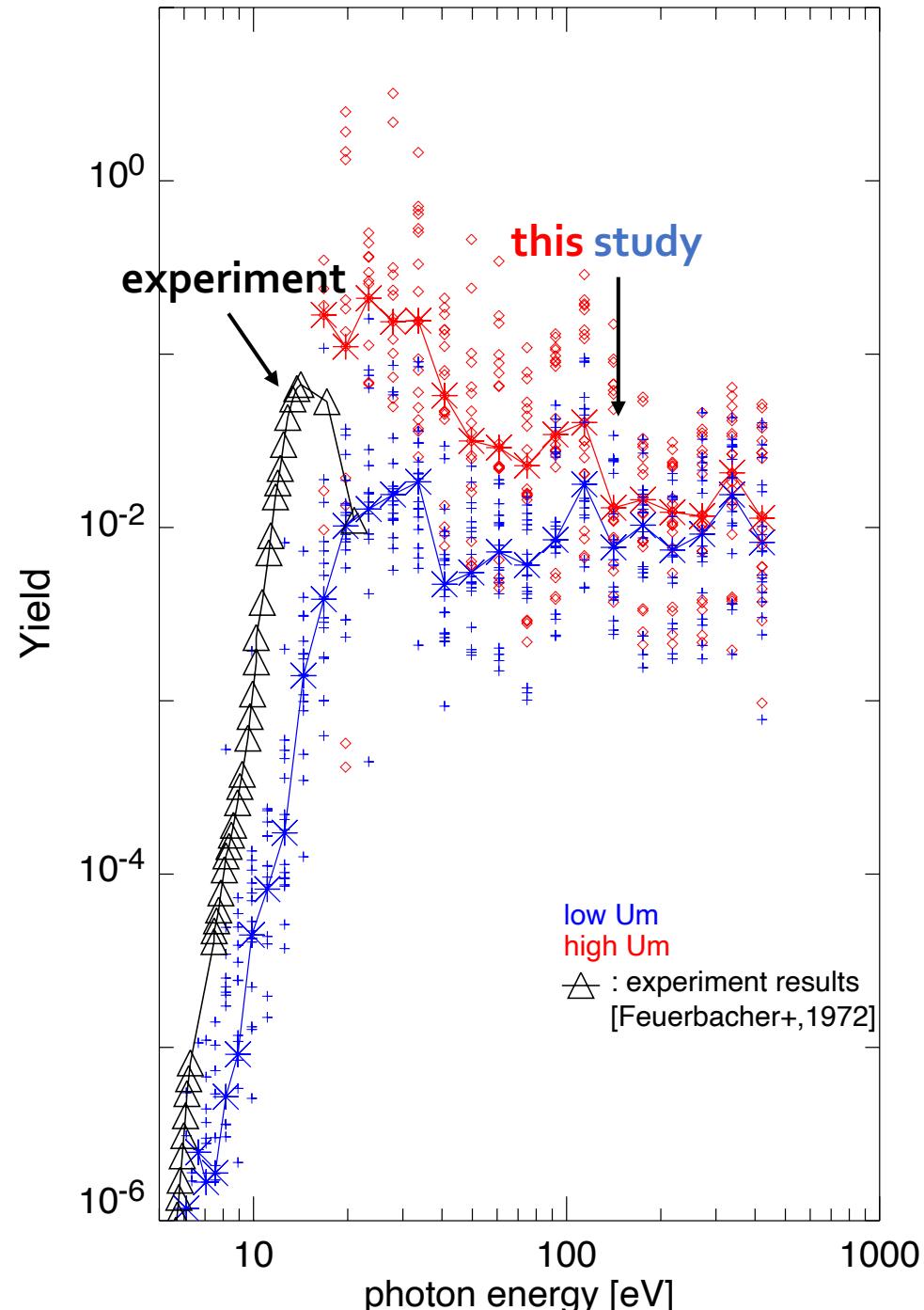
$$f(\varepsilon)d\varepsilon = \int_W^\infty S(E)Y(E)F(\varepsilon, E)dE d\varepsilon$$

- $f(\varepsilon)$ : photo e flux - ARTEMIS data
- $S(E)$ : photon flux – FISM2
- $F(\varepsilon, E)$ : probability function
- $Y(E)$ : photoemission yield
  - Matrix inversion  $\rightarrow Y(E)$



# Calculated Yield with PFs in Liter.

- $\Delta$ : experiment results
- $+/\diamond$ : calculated yields for 5 probability functions (PF) for all 4 selected dates
  - Red: assumed high  $U_m$  (=lunar surf. potential)
  - Blue: assumed low  $U_m$
- This study (red/blue lines):
  - Yield  $\sim 0.01$  for photons  $> \sim 30$  eV, roughly constant
  - Uncertainty in yield is 1-order of magnitude
  - Unknown  $U_m$  affects more at low energies
  - **A sensitivity study shows 3-4 orders of magnitude uncertainty in yield because of unknown PFs (assumed in liter.)**



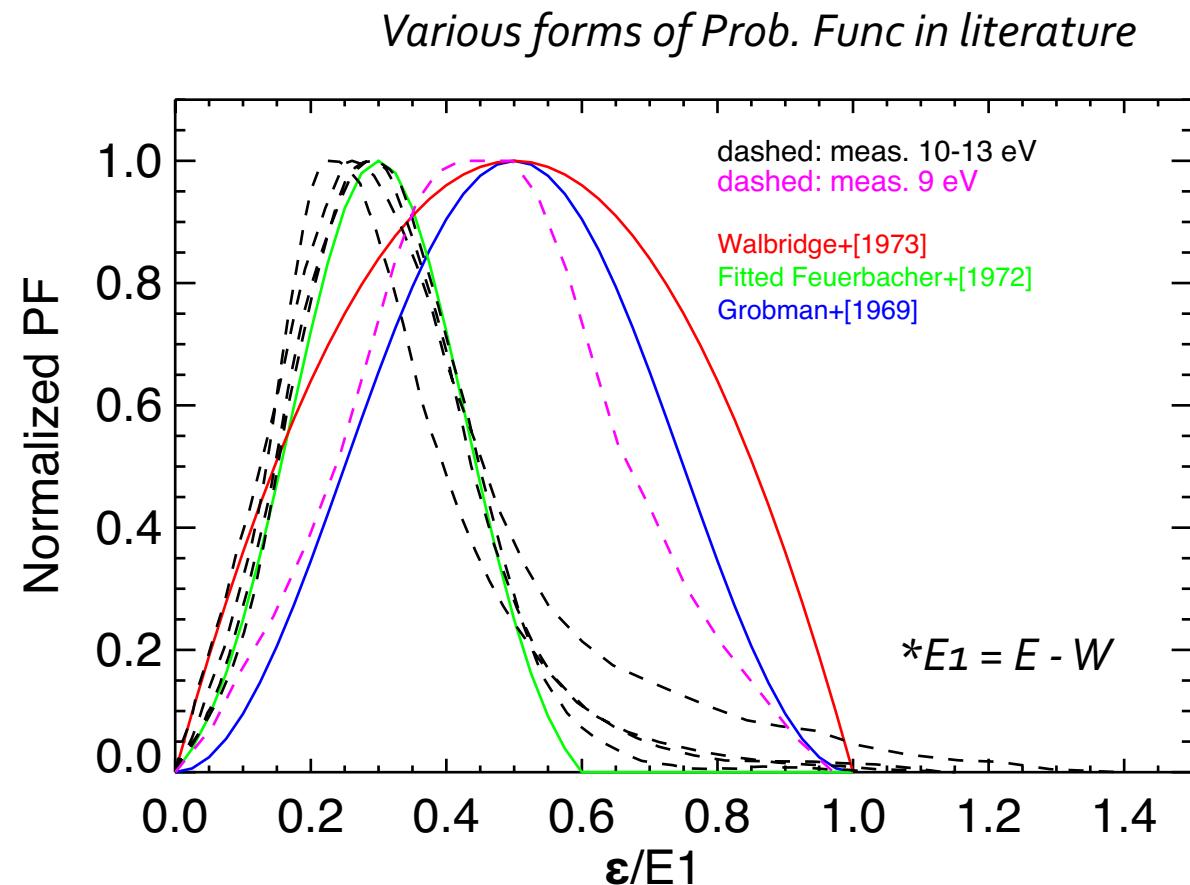
# Summary

- We make the first report of oxygen Auger electron observations at the Moon by the ARTEMIS spacecraft
- We infer a lower bound of  $10^{-3}$  in photoemission yield of the lunar surface for photon energies  $>\sim 20$  eV
- Uncertainties over 3-4 orders of magnitude in yields are found, motivating future experiments on lunar samples for a better understanding
- Xu, S., Poppe, A. R., Harada, Y., Halekas, J. S., & Chamberlin, P. C. (2021). *Lunar photoemission yields inferred from ARTEMIS measurements*. *Journal of Geophysical Research: Planets*, 126, e2020JE006790. <https://doi.org/10.1029/2020JE006790>

# Solving Photoemission Yield

$$f(\varepsilon)d\varepsilon = \int_W^\infty S(E)Y(E)F(\varepsilon, E)dE d\varepsilon$$

- $E$ : photon energy
- $\varepsilon$ : electron energy
- $W$ : work function  $\sim 6$  eV
- $f(\varepsilon)$ : photoelectron flux -- ARTEMIS data
- $S(E)$ : photon flux – FISM2
- $F(\varepsilon, E)$ : probability function – assumed in liter.
  - *probability distribution of photo e- flux as a function of  $\varepsilon$  produced by a photon beam at  $E$*
- $Y(E)$ : photoemission yield
  - *Matrix inversion  $\rightarrow Y(E)$*



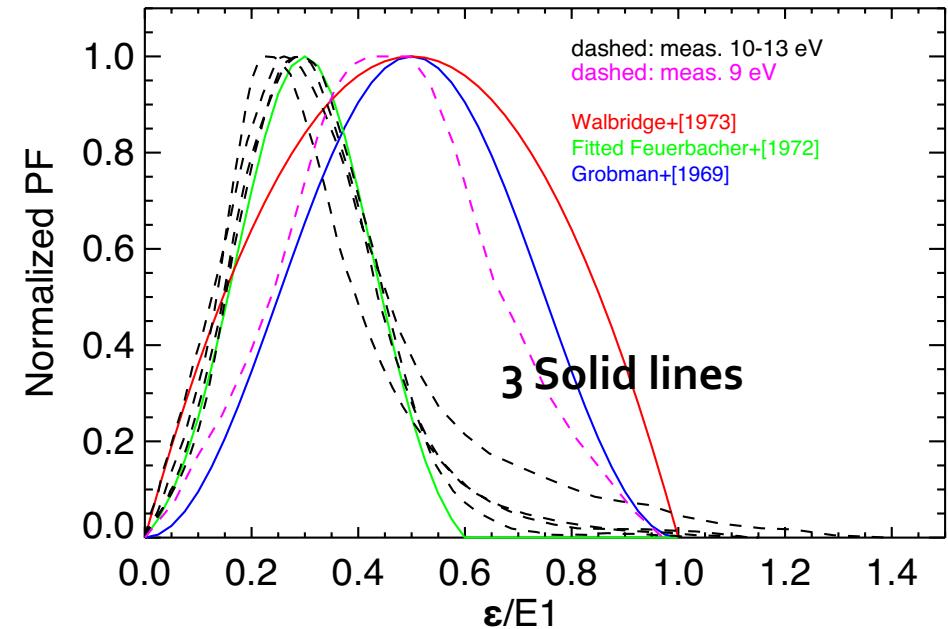
# 5 Probability Functions

$$F = A_0 \sin(\pi \varepsilon/E_1)^2/E_1; \text{ (Grobman & Blank, 1969);}$$

$$F = A_1 \varepsilon * (E_1 - \varepsilon)/E_1^3; \text{ (Reasoner & Burke, 1972; Walbridge, 1973)}$$

$$F = A_2 \left[ \exp\left(-\left(\frac{0.3 - (\varepsilon/E_1)}{0.182}\right)^2\right) - \exp\left(-\left(\frac{0.3}{0.182}\right)^2\right) \right]$$

- Plus, 2 delta functions
  - $\delta(\varepsilon/E_1 = 1)$ : A photon with  $E_1$  producing solely photo e- at  $\varepsilon=E_1$
  - $\delta(\varepsilon/E_1 = 0.5)$ : A photon with  $E_1$  producing solely photo e- at  $\varepsilon=0.5E_1$



# Sensitivity Study with Delta Func

- Prob Func actually unknown for photon energies > 20 eV
- Sensitivity study with delta functions  $\delta(x)$ ,  $x = \varepsilon/E_1$ 
  - A photon beam with  $E$  ( $E_1 = E-W$ ) producing e- at  $\varepsilon$  only
  - Conceptually, smaller  $x$ , smaller  $\varepsilon$ , more e- produced by a single photon → a higher yield
  - Lower bound of ~0.001 in yield ( $x = 1$ )
  - 3-4 orders of magnitude uncertainty in yield
    - Yield for metal (>100 eV) ~ 0.1
- More to uncertainties in yield:
  - **different cases**: a factor of 2-3 uncertainty
  - **unknown in  $U_m$** : a factor of few uncertainty for low  $E_1$
  - **unknown prob func**: orders of magnitude uncertainty

